

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval

Independent Testing Laboratory IECQ Certificate No.: IECQ-L ULTW 16.0003-13

CB Certificate No.: 50600530 ITL

Schedule Number: IECQ-L ULTW 16.0003-13-S Rev No.: 1 Revision Date: 2023/08/15 Page 1 of 2

Appendix-1 (50600530 ITL) Schedule of Scope to Certificate of Approval

Tests	Standards/Procedures	
Scanning Acoustic Tomography (SAT)	T-EFA-3	
Optical Microscope (OM)	T-OMI-3	
High Temperature Operation Life test (HTOL)	IEC 60068-2-1, JESD22-A108	
Low Temperature Operation Life test (LTOL)	IEC 60068-2-1, JESD22-A108	
Bias Life test (BLT)	JESD22-A108	
Temperature Cycling test (TCT)	JESD22-A104	
Temperature variation test (TCC)	IEC 60068-2-14/33	
Thermal Shock test (TST)	JESD22-A106	
High Temperature Storage test (HTST)	IEC 60068-2-2, JESD22-A103	
Low Temperature Storage test (LTST)	IEC 60068-2-1, JESD22-A119	
Pressure Cooker test (PCT/UB-HAST)	JESD22-A102, JESD22-A118	
Highly Accelerated Stress test (HAST)	JESD22-A110	
Temperature and Humidity Storage test (THST)	IEC 60068-2-3, JEDEC22 A101	
Temperature and Humidity with Bias test (THB)	JEDEC22 A101	
High Temperature Reverse Bias test (HTRB)	JESD22-A108	
High Temperature Gate Bias test (HTGB)	JESD22-A108	
High Humidity High Temperature Reverse Bias	JESD22-A101	

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test (H3TRB)	
Intermittent Operational Life test (IOL)	MIL-STD-750 Method 1037
Pre-conditioning test	JESD22-A113
Reflow test	J-STD-020
Solderability test	J-STD-002 S230605136
Surface Mount Technology (SMT)	IPC-A-610, IPC-A-600
Drop test	ISTA 2A, IEC 60068-2-32
Vibration test and Shock Test	IEC 60068-2-6/27/29/34/64
Electro-migration test	IPC TM650 2.6.25
Conductive resistance test	IPC 9701

Technical Reviewer of DQS:	Michael Chou	Date:	8/15/2023

